

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)							
PCN #: TB1 9	004-04	DATE: 6-N	May-2019	MEANS (OF DISTING	UISHING CI	HANGED DEVICES:
Product Affected	: F0424NTGK, F0424	NTGK8		☐ Produc ☐ Back N ☐ Date C ☐ Other	1ark		to the test location is y IDT and available on
Date Effective:	6-Jun-2019						
Contact:	IDT PCN DESK			Attachmer	nt:	Yes	□ No
E-mail:	pcndesk@idt.com			Samples:	Please conta sample requ		sales representative for
DESCRIPTION	AND PURPOSE OF CH	ANGE:					
☐ Die Technolo ☐ Wafer Fabrica ☐ Assembly Pro ☐ Equipment ☐ Material ☐ Testing ☐ Manufacturing ☐ Data Sheet ☐ Other	ation Process cess	as an altern tested in ID		or Test prod Ialaysia fac	cess for the s		g Giga Solution, Taiwan ucts that are presently
	QUALIFICATION SUN ected change to the produce.		eliability perf	formance.	Please refer t	to Attachment	t I for Electrical
IDT records indito grant approva it will be assume IDT reserves the	CKNOWLEDGMENT (icate that you require writt I or request additional info ed that this change is accept tright to ship either version rsion has been depleted.	en notificatio ormation. If II otable.	on of this char DT does not i	receive ack	knowledgeme	ent within 30	days of this notice
Customer:				Appro	oval for sh	ipments pri	ior to effective date.
Name/Date:			E-I	Mail Addre	ess:		
Title:			Pho	one# /Fax#	! :		
CUSTOMER C							
IDE ACTOR	I ED CHEVE OF DE CO	TD/E					
	LEDGMENT OF RECE	IPT:					
RECD. BY:				DATE: _			



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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN #: TB1904-04

PCN Type: Manufacturing Site - Alternate Test Location

Data Sheet Change: None

Detail Of Change:

This notification is to advise our customers that IDT is adding Giga Solution, Taiwan as an alternate facility for Test process for the selective products that are presently tested in IDT Penang, Malaysia facility.

This change will allow IDT the flexibility to ship from either facilities and will provide the increased capacity, flexibility and shorter lead time to meet market demand.

There is no change in the Test processing flows. Load boards are the same at the qualified facilities. IDT has completed the electrical test correlation and based on the test results we do not anticipate any impact on device performance. The testing is fully compatible and transferrable between the test facilities with no change to the test coverage.

If you require samples to conduct evaluations, please contact your local sales representative to acknowledge this PCN and request samples.



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN #: TB1904-04

Qualification Information and Qualification Data: Electrical Test Correlation Results

Vehicle: F0424

Sample size: 10 good and 5 reject units; 10 loop test correlation

Description	Existing Test (IDT, Penang)	Alternate Test (Giga Solution, Taiwan)		
Tester Platform	J750	LTX		
Test Program	F0424_FT_rev1.2	F0424_rev01		
Test Site	Quad Site	Quad Site		
Test Temperature	Ambient	Ambient		
Test Correlation Results	100%	100%		
Number of Good Units	10 pcs	10 pcs		
10 good units datalog correlation	Passed	Passed		
Number of Loop Test	10	10		
10 good unit datalog correlation	Passed	Passed		
Number of Reject Units	5 pcs	5 pcs		
5 reject units datalog correlation	Passed	Passed		